

Notice of References Cited

Application/Control No.

10/661,503

Applicant(s)/Patent Under
Reexamination
HIKAWA ET AL.

Examiner

PHILIP C. LEE

Art Unit

2452

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,815,152	09-1998	Collier et al.	715/839
*	B	US-6,122,633	09-2000	Leymann et al.	707/10
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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